# AMDA

## Am29DL400B

## 4 Megabit (512 K x 8-Bit/256 K x 16-Bit)

## CMOS 3.0 Volt-only, Simultaneous Operation Flash Memory

#### **DISTINCTIVE CHARACTERISTICS**

#### ■ Simultaneous Read/Write operations

- Host system can program or erase in one bank, then immediately and simultaneously read from the other bank
- Zero latency between read and write operations
- Read-while-erase
- Read-while-program

#### Single power supply operation

- 2.7 to 3.6 volt read and write operations for battery-powered applications
- Manufactured on 0.35 µm process technology

#### High performance

- Access times as fast as 70 ns

#### Low current consumption (typical values at 5 MHz)

- 7 mA active read current
- 21 mA active read-while-program or read-whileerase current
- 17 mA active program-while-erase-suspended current
- 200 nA in standby mode
- 200 nA in automatic sleep mode
- Standard t<sub>CE</sub> chip enable access time applies to transition from automatic sleep mode to active mode

#### ■ Flexible sector architecture

- Two 16 Kword, two 8 Kword, four 4 Kword, and six 32 Kword sectors in word mode
- Two 32 Kbyte, two 16 Kbyte, four 8 Kbyte, and six 64 Kbyte sectors in byte mode
- Any combination of sectors can be erased
- Supports full chip erase

#### Unlock Bypass Program Command

 Reduces overall programming time when issuing multiple program command sequences

#### Sector protection

- Hardware method of locking a sector to prevent any program or erase operation within that sector
- Sectors can be locked in-system or via programming equipment
- Temporary Sector Unprotect feature allows code changes in previously locked sectors

## Top or bottom boot block configurations available

#### ■ Embedded Algorithms

- Embedded Erase algorithm automatically pre-programs and erases sectors or entire chip
- Embedded Program algorithm automatically programs and verifies data at specified address

# Minimum 1 million program/erase cycles guaranteed per sector

#### Package options

- -- 44-pin SO
- 48-pin TSOP

#### Compatible with JEDEC standards

- Pinout and software compatible with single-power-supply flash standard
- Superior inadvertent write protection

#### ■ Data# Polling and Toggle Bits

 Provides a software method of detecting program or erase cycle completion

#### Ready/Busy# output (RY/BY#)

 Hardware method for detecting program or erase cycle completion

#### ■ Erase Suspend/Erase Resume

- Suspends or resumes erasing sectors to allow reading and programming in other sectors
- No need to suspend if sector is in the other bank

#### ■ Hardware reset pin (RESET#)

 Hardware method of resetting the device to reading array data

#### GENERAL DESCRIPTION

The Am29DL400B is an 4 Mbit, 3.0 volt-only flash memory device, organized as 262,144 words or 524,288 bytes. The device is offered in 44-pin SO and 48-pin TSOP packages. The word-wide (x16) data appears on DQ0–DQ15; the byte-wide (x8) data appears on DQ0–DQ7. This device requires only a single 3.0 volt  $V_{\rm CC}$  supply to perform read, program, and erase operations. A standard EPROM programmer can also be used to program and erase the device.

The standard device offers access times of 70, 80, 90, and 120 ns, allowing high-speed microprocessors to operate without wait states. Standard control pins—chip enable (CE#), write enable (WE#), and output enable (OE#)—control read and write operations, and avoid bus contention issues.

The device requires only a **single 3.0 volt power sup- ply** for both read and write functions. Internally generated and regulated voltages are provided for the program and erase operations.

# Simultaneous Read/Write Operations with Zero Latency

The Simultaneous Read/Write architecture provides simultaneous operation by dividing the memory space into two banks. Bank 1 contains boot/parameter sectors, and Bank 2 consists of larger, code sectors of uniform size. The device can improve overall system performance by allowing a host system to program or erase in one bank, then immediately and simultaneously read from the other bank, with zero latency. This releases the system from waiting for the completion of program or erase operations.

#### Am29DL400B Features

The device offers complete compatibility with the JEDEC single-power-supply Flash command set standard. Commands are written to the command register using standard microprocessor write timings. Register contents serve as input to an internal state machine that controls the erase and programming circuitry. Write cycles also internally latch addresses and data needed for the programming and erase operations. Reading data out of the device is similar to reading from other Flash or EPROM devices.

Device programming occurs by executing the program command sequence. This initiates the **Embedded Program** algorithm—an internal algorithm that automatically times the program pulse widths and verifies proper cell margin. The **Unlock Bypass** mode facilitates faster programming times by requiring only two write cycles to program data instead of four.

Device erasure occurs by executing the erase command sequence. This initiates the **Embedded Erase** algorithm—an internal algorithm that automatically preprograms the array (if it is not already programmed) before executing the erase operation. During erase, the device automatically times the erase pulse widths and verifies proper cell margin.

The host system can detect whether a program or erase operation is complete by observing the RY/BY# pin, or by reading the DQ7 (Data# Polling) and DQ6 (toggle) **status bits**. After a program or erase cycle has been completed, the device automatically returns to reading array data.

The **sector erase architecture** allows memory sectors to be erased and reprogrammed without affecting the data contents of other sectors. The device is fully erased when shipped from the factory.

Hardware data protection measures include a low  $V_{\rm CC}$  detector that automatically inhibits write operations during power transitions. The hardware sector protection feature disables both program and erase operations in any combination of the sectors of memory. This can be achieved in-system or via programming equipment.

The **Erase Suspend** feature enables the user to put erase on hold for any period of time to read data from, or program data to, any sector within that bank that is not selected for erasure. True background erase can thus be achieved. There is no need to suspend the erase operation if the read data is in the other bank.

The hardware RESET# pin terminates any operation in progress and resets the internal state machine to reading array data. The RESET# pin may be tied to the system reset circuitry. A system reset would thus also reset the device to reading array data, enabling the system microprocessor to read the boot-up firmware from the Flash memory.

The device offers two power-saving features. When addresses have been stable for a specified amount of time, the device enters the **automatic sleep mode**. The system can also place the device into the **standby mode**. Power consumption is greatly reduced in both these modes.

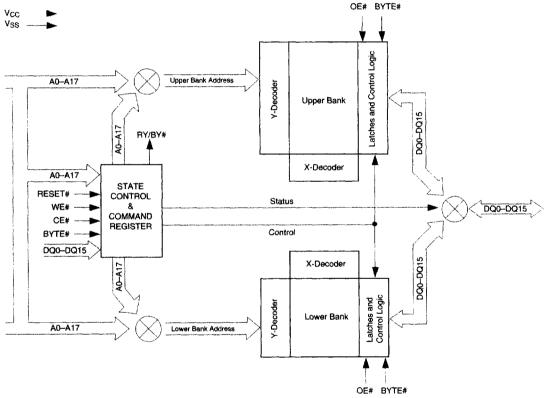
AMD's Flash technology combines years of Flash memory manufacturing experience to produce the highest levels of quality, reliability, and cost effectiveness. The device electrically erases all bits within a sector simultaneously via Fowler-Nordheim tunneling. The bytes are programmed one byte or word at a time using hot electron injection.

#### **PRODUCT SELECTOR GUIDE**

Family Part Number	Am29DL400B							
Speed Options (Full Voltage Range: V <sub>CC</sub> = 2.7 - 3.6 V)	-70	-80	-90	-120				
Max Access Time (ns)	70	80	90	120				
CE# Access (ns)	70	80	90	120				
OE# Access (ns)	30	30	35	50				

Note: See "AC Characteristics" for full specifications.

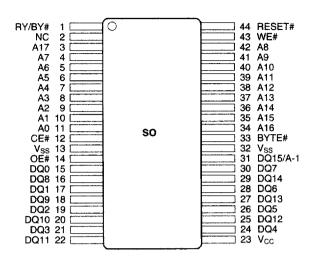
#### **BLOCK DIAGRAM**



## **CONNECTION DIAGRAMS**

				-	
A16 □===	1 ()		48		A15
BYTE#	2		47		A14
V <sub>SS</sub>	3		46		A13
DQ15/A-1	4		45		A12
DQ7 ====	5		44		A11
DQ14	6		43		A10
DQ6 ====	7		42		A9
DQ13 =====	8		41		A8
DQ5 ====	9		40		NC
DQ12 ====	10		39		NC
DQ4 ====	11		38		WE#
V <sub>CC</sub> ====	12		37		RESET#
DQ11	13	Reverse TSOP	36	]	NC
DQ3	14		35		NC
DQ10	15		34		RY/BY#
DQ2	16		33		NC
DQ9 =====	17		32		A17
DQ1 ====	18		31		A7
DQ8	19		30		A6
DQ0	20		29		A5
OE#	21		28		A4
V <sub>SS</sub> ====	22		27		A3
CE#	23		26		A2
A0	24		25	J'	A1

#### **CONNECTION DIAGRAMS**



## PIN DESCRIPTION

A0-A17 = 18 Addresses

DQ0-DQ14 = 15 Data Inputs/Outputs

DQ15/A-1 = DQ15 (Data input/Output, word mode),

A-1 (LSB Address Input, byte mode)

CE# = Chip Enable
OE# = Output Enable

WE# = Write Enable

BYTE# = Selects 8-bit or 16-bit mode

RESET# = Hardware Reset Pin, Active Low

RY/BY# = Ready/Busy Output

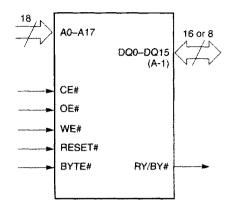
 $V_{CC}$  = 3.0 volt-only single power supply

(see Product Selector Guide for speed options and voltage supply tolerances)

V<sub>SS</sub> = Device Ground

NC = Pin Not Connected Internally

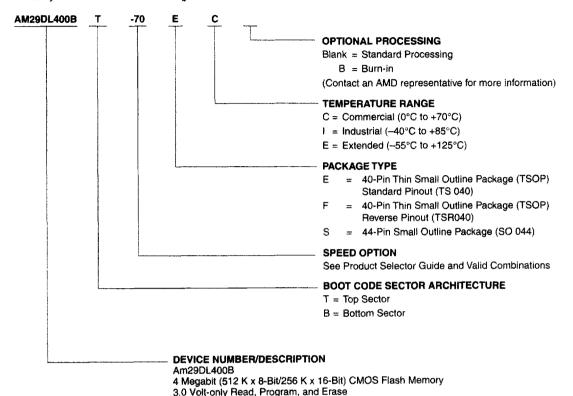
#### LOGIC SYMBOL



#### ORDERING INFORMATION

#### **Standard Products**

AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of the following:



Valid Co	ombinations
AM29DL400BT-70 AM29DL400BB-70	EC, EI, FC, FI, SC, SI
AM29DL400BT-80 AM29DL400BB-80	
AM29DL400BT-90 AM29DL400BB-90	EC, EI, EE, FC, FI, FE. SC, SI, SE
AM29DL400BT-120 AM29DL400BB-120	35, 5., 32

#### **Valid Combinations**

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations to check on newly released combinations.

#### **DEVICE BUS OPERATIONS**

This section describes the requirements and use of the device bus operations, which are initiated through the internal command register. The command register itself does not occupy any addressable memory location. The register is a latch used to store the commands, along with the address and data information needed to execute the command. The contents of

the register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device. Table 1 lists the device bus operations, the inputs and control levels they require, and the resulting output. The following subsections describe each of these operations in further detail.

								DQ8-DQ15
Operation	CE#	OE#	WE#	RESET#	Addresses (Note 1)	DQ0- DQ7	BYTE#	BYTE# = V <sub>IL</sub>
Read	L	L	Н	H	A <sub>IN</sub>	D <sub>OUT</sub>	D <sub>OUT</sub>	DQ8-DQ14 = High-Z,
Write	L	Н	L	Н	A <sub>IN</sub>	D <sub>IN</sub>	D <sub>IN</sub>	DQ15 = A-1
Standby	V <sub>CC</sub> ± 0.3 V	х	х	V <sub>CC</sub> ± 0.3 V	X	High-Z	High-Z	High-Z
Output Disable	L	Н	Н	Н	Х	High-Z	High-Z	High-Z
Reset	X	Х	Х	L	Х	High-Z	High-Z	High-Z
Sector Protect (Note 2)	L	н	L	V <sub>ID</sub>	Sector Address, A6 = L, A1 = H, A0 = L	D <sub>IN</sub>	×	x
Sector Unprotect (Note 2)	L	Н	L	V <sub>ID</sub>	Sector Address, A6 = H, A1 = H, A0 = L	D <sub>IN</sub>	×	x
Temporary Sector Unprotect	X	Х	Х	V <sub>ID</sub>	Ain	Dini	Dini	High-Z

Table 1. Am29DL400B Device Bus Operations

#### Legend:

 $L = Logic\ Low = V_{IL},\ H = Logic\ High = V_{IH},\ V_{ID} = 12.0 \pm 0.5\ V,\ X = Don't\ Care,\ A_{IN} = Address\ In,\ D_{IN} = Data\ In,\ D_{CUT} = Data\ Out$ 

#### Notes

- Addresses are A17:A0 in word mode (BYTE# = V<sub>II</sub>), A17:A-1 in byte mode (BYTE# = V<sub>IL</sub>).
- The sector protect and sector unprotect functions may also be implemented via programming equipment. See the "Sector Protection/Unprotection" section.

## Word/Byte Configuration

The BYTE# pin controls whether the device data I/O pins operate in the byte or word configuration. If the BYTE# pin is set at logic '1', the device is in word configuration, DQ0-15 are active and controlled by CE# and OE#.

If the BYTE# pin is set at logic '0', the device is in byte configuration, and only data I/O pins DQ0-DQ7 are active and controlled by CE# and OE#. The data I/O pins DQ8-DQ14 are tri-stated, and the DQ15 pin is used as an input for the LSB (A-1) address function.

### **Requirements for Reading Array Data**

To read array data from the outputs, the system must drive the CE# and OE# pins to  $V_{IL}$ . CE# is the power control and selects the device. OE# is the output control and gates array data to the output pins. WE# should remain at  $V_{IH}$ . The BYTE# pin determines whether the device outputs array data in words or bytes.

The internal state machine is set for reading array data upon device power-up, or after a hardware reset. This ensures that no spurious alteration of the memory content occurs during the power transition. No command is necessary in this mode to obtain array data. Standard microprocessor read cycles that assert valid addresses on the device address inputs produce valid data on the device data outputs. Each bank remains enabled for read access until the command register contents are aftered.

See "Reading Array Data" for more information. Refer to the AC Read-Only Operations table for timing specifications and to Figure 13 for the timing diagram.  $I_{\rm CC1}$  in the DC Characteristics table represents the active current specification for reading array data.

## Writing Commands/Command Sequences

To write a command or command sequence (which includes programming data to the device and erasing sectors of memory), the system must drive WE# and CE# to  $V_{IL}$ , and OE# to  $V_{IH}$ .

For program operations, the BYTE# pin determines whether the device accepts program data in bytes or words. Refer to "Word/Byte Configuration" for more information.

The device features an **Unlock Bypass** mode to facilitate faster programming. Once a bank enters the Unlock Bypass mode, only two write cycles are required to program a word or byte, instead of four. The "Byte/Word Program Command Sequence" section has details on programming data to the device using both standard and Unlock Bypass command sequences.

An erase operation can erase one sector, multiple sectors, or the entire device. Tables 2 and 3 indicate the address space that each sector occupies. The device address space is divided into two banks: Bank 1 contains the boot/parameter sectors, and Bank 2 contains the larger, code sectors of uniform size. A "bank address" is the address bits required to uniquely select a bank. Similarly, a "sector address" is the address bits required to uniquely select a sector.

If the system writes the autoselect command sequence, the device enters the autoselect mode. The system can then read autoselect codes from the internal register (which is separate from the memory array) on DQ7–DQ0. Standard read cycle timings apply in this mode. Refer to the Autoselect Mode and Autoselect Command Sequence sections for more information.

 $I_{\rm CC2}$  in the DC Characteristics table represents the active current specification for the write mode. The AC Characteristics section contains timing specification tables and timing diagrams for write operations.

# Simultaneous Read/Write Operations with Zero Latency

This device is capable of reading data from one bank of memory while programming or erasing in the other bank of memory. An erase operation may also be suspended to read from or program to another location within the same bank (except the sector being erased).

Figure 19 shows how read and write cycles may be initiated for simultaneous operation with zero latency. I<sub>CC6</sub> and I<sub>CC7</sub> in the DC Characteristics table represent the current specifications for read-while-program and read-while-erase, respectively.

#### Standby Mode

When the system is not reading or writing to the device, it can place the device in the standby mode. In this mode, current consumption is greatly reduced, and the outputs are placed in the high impedance state, independent of the OE# input.

The device enters the CMOS standby mode when the CE# and RESET# pins are both held at  $V_{CC} \pm 0.3$  V. (Note that this is a more restricted voltage range than  $V_{IH\cdot}$ ) If CE# and RESET# are held at  $V_{IH\cdot}$  but not within  $V_{CC} \pm 0.3$  V, the device will be in the standby mode, but the standby current will be greater. The device requires standard access time (t\_{CE}) for read access when the device is in either of these standby modes, before it is ready to read data.

The device also enters the standby mode when the RESET# pin is driven low. Refer to the next section, "RESET#: Hardware Reset Pin".

If the device is deselected during erasure or programming, the device draws active current until the operation is completed.

I<sub>CC3</sub> in the DC Characteristics table represents the standby current specification.

## **Automatic Sleep Mode**

The automatic sleep mode minimizes Flash device energy consumption. The device automatically enables this mode when addresses remain stable for  $t_{ACC}+30$  ns. The automatic sleep mode is independent of the CE#, WE#, and OE# control signals. Standard address access timings provide new data when addresses are changed. While in sleep mode, output data is latched and always available to the system.  $I_{CC4}$  in the DC Characteristics table represents the automatic sleep mode current specification.

#### **RESET#: Hardware Reset Pin**

The RESET# pin provides a hardware method of resetting the device to reading array data. When the RESET# pin is driven low for at least a period of t<sub>RP</sub>, the device **immediately terminates** any operation in progress, tristates all output pins, and ignores all read/write commands for the duration of the RESET# pulse. The device also resets the internal state machine to reading array data. The operation that was interrupted should be reinitiated once the device is ready to accept another command sequence, to ensure data integrity.

Current is reduced for the duration of the RESET# pulse. When RESET# is held at  $V_{SS}\pm0.3$  V, the device draws CMOS standby current ( $I_{CC4}$ ). If RESET# is held at  $V_{IL}$  but not within  $V_{SS}\pm0.3$  V, the standby current will be greater.

The RESET# pin may be tied to the system reset circuitry. A system reset would thus also reset the Flash

memory, enabling the system to read the boot-up firmware from the Flash memory.

If RESET# is asserted during a program or erase operation, the RY/BY# pin remains a "0" (busy) until the internal reset operation is complete, which requires a time of  $t_{READY}$  (during Embedded Algorithms). The system can thus monitor RY/BY# to determine whether the reset operation is complete. If RESET# is asserted when a program or erase operation is not executing (RY/BY# pin is "1"), the reset operation is completed within a time of  $t_{READY}$  (not during Embedded Algorithms). The system can read data  $t_{RH}$  after the RESET# pin returns to  $V_{IH}$ .

Refer to the AC Characteristics tables for RESET# parameters and to Figure 14 for the timing diagram.

#### **Output Disable Mode**

When the OE# input is at  $V_{IH}$ , output from the device is disabled. The output pins are placed in the high impedance state.

Table 2. Am29DL400BT Top Boot Sector Architecture

			S	ector /	Addres	38					
		-	nk ress					Sector Size (Kbytes/	(x8)	(x16)	
Bank	Sector	A17	A16	A15	A14	A13	A12	Kwords)	Address Range	Address Range	
	SA0	0	0	0	Х	Х	Х	64/32	00000h0FFFFh	00000h07FFFh	
	SA1	0	0	1	Х	Х	х	64/32	10000h-1FFFFh	08000h-0FFFFh	
Bank 2	SA2	0	1	0	х	х	х	64/32	20000h-2FFFFh	10000h-17FFFh	
Dank 2	SA3	0	1	1	х	х	Х	64/32	30000h-3FFFFh	18000h-1FFFFh	
	SA4	1	0	0	х	Х	х	64/32	40000h-4FFFFh	20000h-27FFFh	
	SA5	1	0	1	х	Х	×	64/32	50000h-5FFFFh	28000h-2FFFFh	
	SA6	1	1	0	0	0	Х	16/8	60000h-63FFFh	30000h-31FFFh	
	CAZ	1	1	0	0	1	Х	32/16	64000h-6BFFFh	32000h-35FFFh	
	SA7	'	'	0	1	0	х	32/16	64000H-66FFFH	3200011-35FFF11	
	SA8	1	1	0	1	1	0	8/4	6C000h-6DFFFh	36000h-36FFFh	
Danie d	SA9	1	1	0	1	1	1	8/4	6E000h-6FFFFh	37000h-37FFFh	
Bank 1	SA10	1	1	1	0	0	0	8/4	70000h-71FFFh	38000h-38FFFh	
	SA11	1	1	1	0	0	1	8/4	72000h-73FFFh	39000h-39FFFh	
	0440				0	1	х	32/16	74000h 70555	240006 20005	
	SA12	1	1	1	1	0	х	32/16	74000h-7BFFFh	3A000h3DFFFh	
	SA13	1	1	1	1	1	х	16/8	7C000h-7FFFFh	3E000h-3FFFFh	

**Note:** The address range is A17:A-1 if in byte mode (BYTE# =  $V_{IL}$ ). The address range is A17:A0 if in word mode (BYTE# =  $V_{IH}$ ).

Table 3. Am29DL400BB Bottom Boot Sector Architecture

			s	ector	Addres	35						
			nk ress					Sector Size	(x8)	(x16)		
Bank	Sector	A17	A16	A15	A14	A13	A12	(Kbytes/Kwords)	Address Range	Address Range		
	SA13	1	1	1	х	Х	х	64/32	70000h-7FFFFh	38000h-3FFFFh		
	SA12	1	1	0	х	х	х	64/32	60000h-6FFFFh	30000h-37FFFh		
Bank 2	SA11	1	0	1	х	Х	×	64/32	50000h-5FFFFh	28000h-2FFFFh		
Dank 2	SA10	1	0	0	х	Х	х	64/32	40000h-4FFFFh	20000h27FFFh		
	SA9	0	1	1	Х	Х	х	64/32	30000h-3FFFFh	18000h-1FFFFh		
	SA8	0	1	0	х	Х	х	64/32	20000h-2FFFFh	10000h-17FFFh		
	SA7	0	0	1	1	1	Х	16/8	1C000h-1FFFFh	0E000h-0FFFFh		
	SA6	0	0	1	1	0	Х	22/16	e 14000h 1DEEEh 0400/		32/16 14000h-1BFFFh 0A00	0A000h0DFFFh
	SAO	U		,	0	1	х	32/16	1400011-15FFF11	OAGOON-ODEEN		
	SA5	0	0	1	0	0	1	8/4	12000h-13FFFh	09000h-09FFFh		
Bank 1	SA4	0	0	1	0	0	0	8/4	10000h11FFFh	08000h-08FFFh		
Dank	SA3	0	0	0	1	1	1	8/4	0E000h-0FFFFh	07000h-07FFFh		
	SA2	0	0	0	1	1	0	8/4	0C000h-0DFFFh	06000h-06FFFh		
	SA1			0	1	0	х	2040	04000h0BFFFh	02000h-05FFFh		
	SAI	0	0	U	0	1	х	32/16	2/10   04000N-0BFFFN   0200			
	SA0	0	0	0	0	0	х	16/8	00000h-03FFFh	00000h-01FFFh		

**Note:** The address range is A17:A-1 if in byte mode (BYTE# =  $V_{IL}$ ). The address range is A17:A0 if in word mode (BYTE# =  $V_{IH}$ ).

#### **Autoselect Mode**

The autoselect mode provides manufacturer and device identification, and sector protection verification, through identifier codes output on DQ7–DQ0. This mode is primarily intended for programming equipment to automatically match a device to be programmed with its corresponding programming algorithm. However, the autoselect codes can also be accessed in-system through the command register.

When using programming equipment, the autoselect mode requires V<sub>ID</sub> (11.5 V to 12.5 V) on address pin A9. Address pins A6, A1, and A0 must be as shown in

Table 4. In addition, when verifying sector protection, the sector address must appear on the appropriate highest order address bits (see Tables 2 and 3). Table 4 shows the remaining address bits that are don't care. When all necessary bits have been set as required, the programming equipment may then read the corresponding identifier code on DQ7-DQ0.

To access the autoselect codes in-system, the host system can issue the autoselect command via the command register, as shown in Table 5. This method does not require V<sub>ID</sub>. Refer to the Autoselect Command Sequence section for more information.

A17 A11 **A8** Δ5 DQ8 DQ7 to to to to to to Description CE# OE# WE# **A7 DQ15** Mode A12 A10 A9 A6 A2 A1 A0 DQ0 Manufacturer ID: AMD L L Н BA Х Vin Х L Х L L х 01h Device ID: Word L L Н 22h OC. Am29DL400B Х BA Х L Х Н Vin L Byte L L Н Х 00 (Top Boot Block) L L 0F Device ID: Word Н 22h Am29DL400B BA Х Х L X L Н VID Byte L L Н χ ٥F (Bottom Boot Block) 01h Х (protected) Sector Protection Verification 1. L H SA Х  $V_{ID}$ Х Ł Х Н L 00h χ (unprotected)

Table 4. Am29DL400B Autoselect Codes (High Voltage Method)

**Note:**  $L = Logic Low = V_{IL}$ ,  $H = Logic High = V_{IH}$ , BA = Bank Address, SA = Sector Address, X = Don't care.

#### **Sector Protection/Unprotection**

The hardware sector protection feature disables both program and erase operations in any sector. The hardware sector unprotection feature re-enables both program and erase operations in previously protected sectors. Sector protection/unprotection can be implemented via two methods.

The primary method requires  $V_{\rm ID}$  on the RESET# pin only, and can be implemented either in-system or via programming equipment. Figure 2 shows the algorithms and Figure 24 shows the timing diagram. This method uses standard microprocessor bus cycle timing. For sector unprotect, all unprotected sectors must first be protected prior to the first sector unprotect write cycle.

The alternate method intended only for programming equipment requires  $V_{\text{ID}}$  on address pin A9 and OE#. This method is compatible with programmer routines written for earlier 3.0 volt-only AMD flash devices. Publication number 22145 contains further details; contact an AMD representative to request a copy.

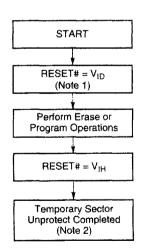
The device is shipped with all sectors unprotected. AMD offers the option of programming and protecting sectors at its factory prior to shipping the device through AMD's ExpressFlash<sup>TM</sup> Service. Contact an AMD representative for details.

It is possible to determine whether a sector is protected or unprotected. See the Autoselect Mode section for details.

#### **Temporary Sector Unprotect**

This feature allows temporary unprotection of previously protected sectors to change data in-system. The Sector Unprotect mode is activated by setting the

RESET# pin to  $V_{ID}$  (11.5 V - 12.5 V). During this mode, formerly protected sectors can be programmed or erased by selecting the sector addresses. Once  $V_{ID}$  is removed from the RESET# pin, all the previously protected sectors are protected again. Figure 1 shows the algorithm, and Figure 23 shows the timing diagrams, for this feature.



21606C-5

- 1. All protected sectors unprotected.
- All previously protected sectors are protected once again.

Figure 1. Temporary Sector Unprotect Operation

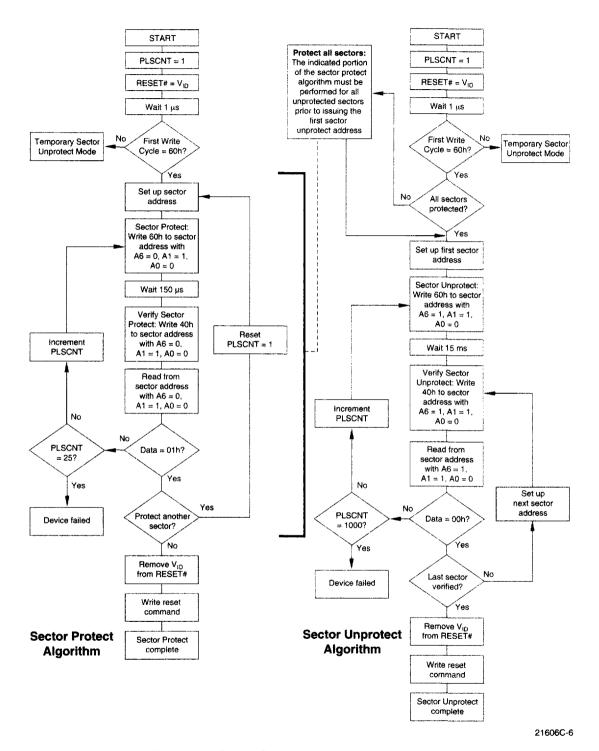


Figure 2. In-System Sector Protect/Unprotect Algorithms

#### **Hardware Data Protection**

The command sequence requirement of unlock cycles for programming or erasing provides data protection against inadvertent writes (refer to Table 5 for command definitions). In addition, the following hardware data protection measures prevent accidental erasure or programming, which might otherwise be caused by spurious system level signals during V<sub>CC</sub> power-up and power-down transitions, or from system noise.

#### Low V<sub>CC</sub> Write Inhibit

When  $V_{CC}$  is less than  $V_{LKO}$ , the device does not accept any write cycles. This protects data during  $V_{CC}$  power-up and power-down. The command register and all internal program/erase circuits are disabled, and the device resets to reading array data. Subsequent writes are ignored until  $V_{CC}$  is greater than  $V_{LKO}$ . The system must provide the proper signals to the control pins to

prevent unintentional writes when  $V_{CC}$  is greater than  $V_{LKO}$ 

#### Write Pulse "Glitch" Protection

Noise pulses of less than 5 ns (typical) on OE#, CE# or WE# do not initiate a write cycle.

#### Logical Inhibit

Write cycles are inhibited by holding any one of OE# =  $V_{IL}$ , CE# =  $V_{IH}$  or WE# =  $V_{IH}$ . To initiate a write cycle, CE# and WE# must be a logical zero while OE# is a logical one.

#### **Power-Up Write Inhibit**

If WE# = CE# =  $V_{\rm IL}$  and OE# =  $V_{\rm IH}$  during power up, the device does not accept commands on the rising edge of WE#. The internal state machine is automatically reset to reading array data on power-up.

#### **COMMAND DEFINITIONS**

Writing specific address and data commands or sequences into the command register initiates device operations. Table 5 defines the valid register command sequences. Writing incorrect address and data values or writing them in the improper sequence resets the device to reading array data.

All addresses are latched on the falling edge of WE# or CE#, whichever happens later. All data is latched on the rising edge of WE# or CE#, whichever happens first. Refer to the appropriate timing diagrams in the AC Characteristics section.

## **Reading Array Data**

The device is automatically set to reading array data after device power-up. No commands are required to retrieve data. Each bank is ready to read array data after completing an Embedded Program or Embedded Erase algorithm.

After the device accepts an Erase Suspend command, the corresponding bank enters the erase-suspend-read mode, after which the system can read data from any non-erase-suspended sector within the same bank. After completing a programming operation in the Erase Suspend mode, the system may once again read array data with the same exception. See the Erase Suspend/Erase Resume Commands section for more information.

The system *must* issue the reset command to return a bank to the read (or erase-suspend-read) mode if DQ5 goes high during an active program or erase operation, or if the bank is in the autoselect mode. See the next section, Reset Command, for more information.

See also Requirements for Reading Array Data in the Device Bus Operations section for more information.

The Read-Only Operations table provides the read parameters, and Figure 13 shows the timing diagram.

## **Reset Command**

Writing the reset command resets the banks to the read or erase-suspend-read mode. Address bits are don't cares for this command.

The reset command may be written between the sequence cycles in an erase command sequence before erasing begins. This resets the bank to which the system was writing to reading array data. Once erasure begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in a program command sequence before programming begins. This resets the bank to which the system was writing to the reading array data. If the program command sequence is written to a bank that is in the Erase Suspend mode, writing the reset command returns that bank to the erase-suspend-read mode. Once programming begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in an autoselect command sequence. Once in the autoselect mode, the reset command must be written to return to reading array data. If a bank entered the autoselect mode while in the Erase Suspend mode, writing the reset command returns that bank to the erase-suspend-read mode.

If DQ5 goes high during a program or erase operation, writing the reset command returns the banks to reading array data (or erase-suspend-read mode if that bank was in Erase Suspend).

#### **Autoselect Command Sequence**

The autoselect command sequence allows the host system to access the manufacturer and devices codes, and determine whether or not a sector is protected. Table 5 shows the address and data requirements. This method is an alternative to that shown in Table 4, which is intended for PROM programmers and requires  $V_{\rm ID}$  on address pin A9. The autoselect command sequence may be written to an address within a bank that is either in the read or erase-suspend-read mode. The autoselect command may not be written while the device is actively programming or erasing in the other bank.

The autoselect command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle that contains the bank address and the autoselect command. The addressed bank then enters the autoselect mode. The system may read at any address within the same bank any number of times without initiating another autoselect command sequence:

- A read cycle at address (BA)XX00h (where BA is the bank address) returns the manufacturer code.
- A read cycle at address (BA)XX01h in word mode (or (BA)XX02h in byte mode) returns the device code.
- A read cycle to an address containing a sector address (SA) within the same bank, and the address 02h on A7–A0 in word mode (or the address 04h on A6–A-1 in byte mode) returns 01h if the sector is protected, or 00h if it is unprotected. Refer to Tables 2 and 3 for valid sector addresses.

The system may continue to read array data from the other bank while a bank is in the autoselect mode. To exit the autoselect mode, the system must write the reset command to return both banks to reading array data. If a bank enters the autoselect mode while erase suspended, a reset command returns that bank to the erase-suspend-read mode. A subsequent Erase Resume command returns the bank to the erase operation.

## **Byte/Word Program Command Sequence**

The system may program the device by word or byte, depending on the state of the BYTE# pin. Programming is a four-bus-cycle operation. The program command sequence is initiated by writing two unlock write cycles, followed by the program set-up command. The program address and data are written next, which in turn initiate the Embedded Program algorithm. The system is not required to provide further controls or timings. The device automatically generates the program pulses and verifies the programmed cell margin. Table

5 shows the address and data requirements for the byte program command sequence.

When the Embedded Program algorithm is complete, that bank then returns to reading array data and addresses are no longer latched. The system can determine the status of the program operation by using DQ7, DQ6, or RY/BY#. Note that while the Embedded Program operation is in progress, the system can read data from the non-programming bank. Refer to the Write Operation Status section for information on these status bits.

Any commands written to the device during the Embedded Program Algorithm are ignored. Note that a hardware reset immediately terminates the program operation. The program command sequence should be reinitiated once that bank has returned to reading array data, to ensure data integrity.

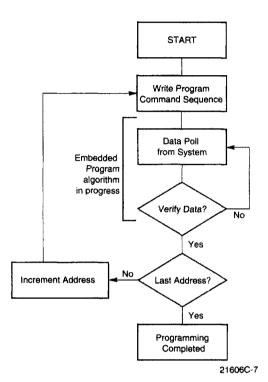
Programming is allowed in any sequence and across sector boundaries. A bit cannot be programmed from "0" back to a "1." Attempting to do so may cause that bank to set DQ5 = 1, or cause the DQ7 and DQ6 status bits to indicate the operation was successful. However, a succeeding read will show that the data is still "0." Only erase operations can convert a "0" to a "1."

#### **Unlock Bypass Command Sequence**

The unlock bypass feature allows the system to program bytes or words to a bank faster than using the standard program command sequence. The unlock bypass command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle containing the unlock bypass command, 20h. That bank then enters the unlock bypass mode. A two-cycle unlock bypass program command sequence is all that is required to program in this mode. The first cycle in this sequence contains the unlock bypass program command. A0h; the second cycle contains the program address and data. Additional data is programmed in the same manner. This mode dispenses with the initial two unlock cycles required in the standard program command sequence, resulting in faster total programming time. Table 5 shows the requirements for the command sequence.

During the unlock bypass mode, only the Unlock Bypass Program and Unlock Bypass Reset commands are valid. To exit the unlock bypass mode, the system must issue the two-cycle unlock bypass reset command sequence. The first cycle must contain the bank address and the data 90h. The second cycle need only contain the data 00h. The bank then returns to reading array data.

Figure 3 illustrates the algorithm for the program operation. Refer to the Erase and Program Operations table in the AC Characteristics section for parameters, and Figure 17 for timing diagrams.



Note: See Table 5 for program command sequence.

Figure 3. Program Operation

## **Chip Erase Command Sequence**

Chip erase is a six bus cycle operation. The chip erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock write cycles are then followed by the chip erase command, which in turn invokes the Embedded Erase algorithm. The device does *not* require the system to preprogram prior to erase. The Embedded Erase algorithm automatically preprograms and verifies the entire memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations. Table 5 shows the address and data requirements for the chip erase command sequence.

When the Embedded Erase algorithm is complete, that bank returns to reading array data and addresses are no longer latched. The system can determine the status of the erase operation by using DQ7, DQ6, DQ2, or RY/BY#. Refer to the Write Operation Status section for information on these status bits.

Any commands written during the chip erase operation are ignored. However, note that a **hardware reset** immediately terminates the erase operation. If that occurs, the chip erase command sequence should be reinitiated once that bank has returned to reading array data, to ensure data integrity.

Figure 4 illustrates the algorithm for the erase operation. Refer to the Erase and Program Operations tables in the AC Characteristics section for parameters, and Figure 18 section for timing diagrams.

#### **Sector Erase Command Sequence**

Sector erase is a six bus cycle operation. The sector erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock cycles are written, and are then followed by the address of the sector to be erased, and the sector erase command. Table 5 shows the address and data requirements for the sector erase command sequence.

The device does *not* require the system to preprogram prior to erase. The Embedded Erase algorithm automatically programs and verifies the entire memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations.

After the command sequence is written, a sector erase time-out of 50 µs occurs. During the time-out period, additional sector addresses and sector erase commands may be written. Loading the sector erase buffer may be done in any sequence, and the number of sectors may be from one sector to all sectors. The time between these additional cycles must be less than 50 µs. otherwise the last address and command may not be accepted, and erasure may begin. It is recommended that processor interrupts be disabled during this time to ensure all commands are accepted. The interrupts can be re-enabled after the last Sector Erase command is written. Any command other than Sector Erase or Erase Suspend during the time-out period resets that bank to reading array data. The system must rewrite the command sequence and any additional addresses and commands.

The system can monitor DQ3 (in the erasing bank) to determine if the sector erase timer has timed out (See the section on DQ3: Sector Erase Timer.). The time-out begins from the rising edge of the final WE# pulse in the command sequence.

When the Embedded Erase algorithm is complete, the bank returns to reading array data and addresses are no longer latched. Note that while the Embedded Erase operation is in progress, the system can read data from

the non-erasing bank. The system can determine the status of the erase operation by reading DQ7, DQ6, DQ2, or RY/BY# in the erasing bank. Refer to the Write Operation Status section for information on these status bits.

Once the sector erase operation has begun, only the Erase Suspend command is valid. All other commands are ignored. However, note that a **hardware reset** immediately terminates the erase operation. If that occurs, the sector erase command sequence should be reinitiated once that bank has returned to reading array data, to ensure data integrity.

Figure 4 illustrates the algorithm for the erase operation. Refer to the Erase and Program Operations tables in the AC Characteristics section for parameters, and Figure 18 section for timing diagrams.

### **Erase Suspend/Erase Resume Commands**

The Erase Suspend command, B0h, allows the system to interrupt a sector erase operation and then read data from, or program data to, any sector not selected for erasure. The bank address is required when writing this command. This command is valid only during the sector erase operation, including the 50 µs time-out period during the sector erase command sequence. The Erase Suspend command is ignored if written during the chip erase operation or Embedded Program algorithm.

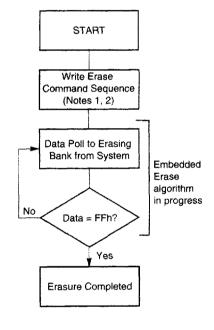
When the Erase Suspend command is written during the sector erase operation, the device requires a maximum of 20 µs to suspend the erase operation. However, when the Erase Suspend command is written during the sector erase time-out, the device immediately terminates the time-out period and suspends the erase operation.

After the erase operation has been suspended, the bank enters the erase-suspend-read mode. The system can read data from or program data to any sector not selected for erasure. (The device "erase suspends" all sectors selected for erasure.) Reading at any address within erase-suspended sectors produces status information on DQ7–DQ0. The system can use DQ7, or DQ6 and DQ2 together, to determine if a sector is actively erasing or is erase-suspended. Refer to the Write Operation Status section for information on these status bits.

After an erase-suspended program operation is complete, the bank returns to the erase-suspend-read mode. The system can determine the status of the program operation using the DQ7 or DQ6 status bits, just as in the standard Byte Program operation. Refer to the Write Operation Status section for more information.

In the erase-suspend-read mode, the system can also issue the autoselect command sequence. Refer to the Autoselect Mode and Autoselect Command Sequence sections for details.

To resume the sector erase operation, the system must write the Erase Resume command. The bank address of the erase-suspended bank is required when writing this command. Further writes of the Resume command are ignored. Another Erase Suspend command can be written after the chip has resumed erasing.



21606C-8

- 1. See Table 5 for erase command sequence.
- See the section on DQ3 for information on the sector erase timer.

Figure 4. Erase Operation

Table 5. Am29DL400B Comr	nand D	efinitions
--------------------------	--------	------------

	O		ø					Bus	Cycles	(Notes 2-	-5)					
	Command Sequence		Cycles	Fir	st	Sec	ond	Thire	i	Four	th	Fif	th	Six	th	
	(Note 1)		ठ	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data	
Rea	ad (Note 6)		1	RA	RD											
Res	set (Note 7)		1	XXX	F0											
	Manufacturer ID	Word	4	555	AA	2AA	55	(BA)555	90	(BA)X00	01					
	Manufacturer ID	Byte	4	AAA	~~	555	55	(BA)AAA	30	(BK)X00	·					
8	Device ID,	Word	4	555	AA	2AA	55	(BA)555	90	(BA)X01	220C					
Autoselect (Note	Top Boot Block	Byte		(BA)X02	0C			-1-4								
Ę	Device ID.	Word	4	555	AA	2AA	55	(BA)555	90	(BA)X01	220F					
<u>\$</u>	Bottom Boot Block	Byte	*	AAA	**	555	55	(BA)AAA	30	(BA)X02	OF					
SO		Word		555		2AA		(BA)555		(SA)	XX00					
Ā	Sector Protect	WOIG	4	333	AA	244	55	(BA)555	90	X02	XX01					
	Verify (Note 9)	Byte	7	AAA	^^	555	75	(BA)AAA	90	(SA)	00					
	_	Dyte		700		333		(DA)AAA		X04	01					
Des		Word	4	555	AA	2AA	55	555	AO	PA	PA	PD	ļ			
MIO	gram	Byte	7	AAA	<u> </u>	555	- 55	AAA	1.0							
Limb	and Dunana	Word	3	555	AA	2AA	55	555	20							
UHII	ock Bypass	Byte	J	AAA		555	33	AAA	20							
Uni	ock Bypass Program	Note 10)	2	XXX	A0	PA	PD									
Uni	ock Bypass Reset (No	ote 11)	2	BA	90	XXX	00		<u> </u>						ļ	
۲.		Word	6	555	AA	2AA	55	555	- 80	555	AA	2AA	55	555	10	
Cni	p Erase	Byte	0	AAA	_^^	555	35	AAA		AAA	555		AAA			
0	utor Eroso	Word	6	555	AA	2AA	- 55	555	80	555	AA	2AA	55	SA	30	
560	ctor Erase	Byte	0	AAA		555	555	AAA	00	AAA		555	J	·	L	
Era	se Suspend (Note 12	)	1	BA	B0										ļ	
Era	se Resume (Note 13)		1	BA	30				l					L		

#### Legend:

X = Don't care

RA = Address of the memory location to be read.

RD = Data read from location RA during read operation.

PA = Address of the memory location to be programmed. Addresses latch on the falling edge of the WE# or CE# pulse, whichever happens later. PD = Data to be programmed at location PA. Data latches on the rising edge of WE# or CE# pulse, whichever happens first.

SA = Address of the sector to be verified (in autoselect mode) or erased. Address bits A17–A12 uniquely select any sector.

BA = Address of the bank that is being switched to autoselect mode, is in bypass mode, or is being erased. Address bits A17–A16 select a bank.

- 1. See Table 1 for description of bus operations.
- 2. All values are in hexadecimal.
- Except when reading array or autoselect data, all bus cycles are write operations.
- Data bits DQ15—DQ8 are don't cares for unlock and command cycles in word mode.
- Address bits A17-A11 are don't cares for unlock and command cycles, unless bank address (BA) is required.
- No unlock or command cycles required when bank is in read mode.
- 7. The Reset command is required to return to reading array data (or to the erase-suspend-read mode if previously in Erase Suspend) when a bank is in the autoselect mode, or if DQ5 is goes high (while the bank is providing status information).

- The fourth cycle of the autoselect command sequence is a read cycle. The system must provide the bank address to obtain the manufacturer or device ID information.
- The data is 00h for an unprotected sector and 01h for a protected sector. See the Autoselect Command Sequence section for more information.
- The Unlock Bypass command is required prior to the Unlock Bypass Program command.
- 11. The Unlock Bypass Reset command is required to return to reading array data when the bank is in the unlock bypass mode.
- 12. The system may read and program in non-erasing sectors, or enter the autoselect mode, when in the Erase Suspend mode. The Erase Suspend command is valid only during a sector erase operation, and requires the bank address.
- 13. The Erase Resume command is valid only during the Erase Suspend mode, and requires the bank address.

#### WRITE OPERATION STATUS

The device provides several bits to determine the status of a write operation in the bank where a program or erase operation is in progress: DQ2, DQ3, DQ5, DQ6, DQ7, and RY/BY#. Table 6 and the following subsections describe the function of these bits. DQ7, RY/BY#, and DQ6 each offer a method for determining whether a program or erase operation is complete or in progress. These three bits are discussed first.

#### DQ7: Data# Polling

The Data# Polling bit, DQ7, indicates to the host system whether an Embedded Program or Erase algorithm is in progress or completed, or whether a bank is in Erase Suspend. Data# Polling is valid after the rising edge of the final WE# pulse in the command sequence.

During the Embedded Program algorithm, the device outputs on DQ7 the complement of the datum programmed to DQ7. This DQ7 status also applies to programming during Erase Suspend. When the Embedded Program algorithm is complete, the device outputs the datum programmed to DQ7. The system must provide the program address to read valid status information on DQ7. If a program address falls within a protected sector, Data# Polling on DQ7 is active for approximately 1 µs, then that bank returns to reading array data.

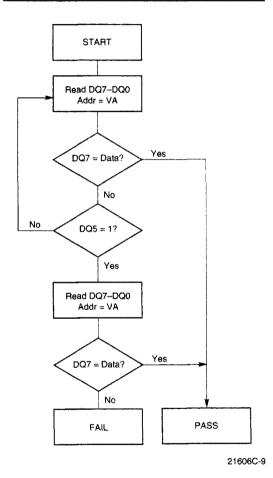
During the Embedded Erase algorithm, Data# Polling produces a "0" on DQ7. When the Embedded Erase algorithm is complete, or if the bank enters the Erase Suspend mode, Data# Polling produces a "1" on DQ7. The system must provide an address within any of the sectors selected for erasure to read valid status information on DQ7.

After an erase command sequence is written, if all sectors selected for erasing are protected, Data# Polling on DQ7 is active for approximately 100 µs, then the bank returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected. However, if the system reads DQ7 at an address within a protected sector, the status may not be valid.

Just prior to the completion of an Embedded Program or Erase operation, DQ7 may change asynchronously with DQ0–DQ6 while Output Enable (OE#) is asserted low. That is, the device may change from providing status information to valid data on DQ7. Depending on when the system samples the DQ7 output, it may read the status or valid data. Even if the device has completed the program or erase operation and DQ7 has valid data, the data outputs on DQ0–DQ6 may be still

invalid. Valid data on DQ0-DQ7 will appear on successive read cycles.

Table 6 shows the outputs for Data# Polling on DQ7. Figure 5 shows the Data# Polling algorithm. Figure 20 in the AC Characteristics section shows the Data# Polling timing diagram.



- VA = Valid address for programming. During a sector erase operation, a valid address is any sector address within the sector being erased. During chip erase, a valid address is any non-protected sector address.
- DQ7 should be rechecked even if DQ5 = "1" because DQ7 may change simultaneously with DQ5.

Figure 5. Data# Polling Algorithm

#### RY/BY#: Ready/Busy#

The RY/BY# is a dedicated, open-drain output pin that indicates whether an Embedded Algorithm is in progress or complete. The RY/BY# status is valid after the rising edge of the final WE# pulse in the command sequence. Since RY/BY# is an open-drain output, several RY/BY# pins can be tied together in parallel with a pull-up resistor to  $V_{\rm CC}$ .

If the output is low (Busy), the device is actively erasing or programming. (This includes programming in the Erase Suspend mode.) If the output is high (Ready), the device is ready to read array data, is in the standby mode, or one of the banks is in the erase-suspend-read mode.

Table 6 shows the outputs for RY/BY#.

#### DQ6: Toggle Bit I

Toggle Bit I on DQ6 indicates whether an Embedded Program or Erase algorithm is in progress or complete, or whether the device has entered the Erase Suspend mode. Toggle Bit I may be read at any address within the programming or erasing bank, and is valid after the rising edge of the final WE# pulse in the command sequence (prior to the program or erase operation), and during the sector erase time-out.

During an Embedded Program or Erase algorithm operation, successive read cycles to any address within the programming or erasing bank cause DQ6 to toggle. The system may use either OE# or CE# to control the read cycles. When the operation is complete, DQ6 stops toggling.

After an erase command sequence is written, if all sectors selected for erasing are protected, DQ6 toggles for approximately 100 µs, then returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected.

The system can use DQ6 and DQ2 together to determine whether a sector is actively erasing or is erase-suspended. When a bank is actively erasing (that is, the Embedded Erase algorithm is in progress), DQ6 toggles. When that bank enters the Erase Suspend mode, DQ6 stops toggling. However, the system must also use DQ2 to determine which sectors are erasing or erase-suspended. Alternatively, the system can use DQ7 (see the subsection on DQ7: Data# Polling).

If a program address falls within a protected sector, DQ6 toggles for approximately 1 µs after the program command sequence is written, then returns to reading array data.

DQ6 also toggles during the erase-suspend-program mode, and stops toggling once the Embedded Program algorithm is complete.

Table 6 shows the outputs for Toggle Bit I on DQ6. Figure 6 shows the toggle bit algorithm. Figure 21 in the "AC Characteristics" section shows the toggle bit timing diagrams. Figure 22 shows the differences between DQ2 and DQ6 in graphical form. See also the subsection on DQ2: Toggle Bit II.

#### DQ2: Toggle Bit II

The "Toggle Bit II" on DQ2, when used with DQ6, indicates whether a particular sector is actively erasing (that is, the Embedded Erase algorithm is in progress), or whether that sector is erase-suspended. Toggle Bit II is valid after the rising edge of the final WE# pulse in the command sequence.

DQ2 toggles when the system reads at addresses within those sectors that have been selected for erasure. (The system may use either OE# or CE# to control the read cycles.) But DQ2 cannot distinguish whether the sector is actively erasing or is erase-suspended. DQ6, by comparison, indicates whether the device is actively erasing, or is in Erase Suspend, but cannot distinguish which sectors are selected for erasure. Thus, both status bits are required for sector and mode information. Refer to Table 6 to compare outputs for DQ2 and DQ6.

Figure 6 shows the toggle bit algorithm in flowchart form, and the section "DQ2: Toggle Bit II" explains the algorithm. See also the DQ6: Toggle Bit I subsection. Figure 21 shows the toggle bit timing diagram. Figure 22 shows the differences between DQ2 and DQ6 in graphical form.

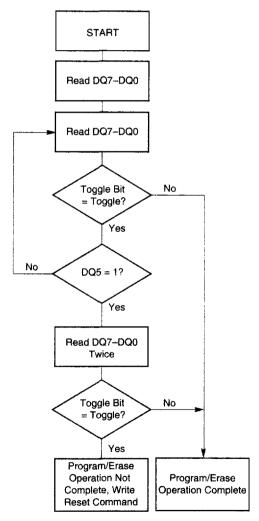
#### Reading Toggle Bits DQ6/DQ2

Refer to Figure 6 for the following discussion. Whenever the system initially begins reading toggle bit status, it must read DQ7–DQ0 at least twice in a row to determine whether a toggle bit is toggling. Typically, the system would note and store the value of the toggle bit after the first read. After the second read, the system would compare the new value of the toggle bit with the first. If the toggle bit is not toggling, the device has completed the program or erase operation. The system can read array data on DQ7–DQ0 on the following read cycle.

However, if after the initial two read cycles, the system determines that the toggle bit is still toggling, the system also should note whether the value of DQ5 is high (see the section on DQ5). If it is, the system should then determine again whether the toggle bit is toggling, since the toggle bit may have stopped toggling just as DQ5 went high. If the toggle bit is no longer toggling, the device has successfully completed the program or erase operation. If it is still toggling, the device did not

completed the operation successfully, and the system must write the reset command to return to reading array data.

The remaining scenario is that the system initially determines that the toggle bit is toggling and DQ5 has not gone high. The system may continue to monitor the toggle bit and DQ5 through successive read cycles, determining the status as described in the previous paragraph. Alternatively, it may choose to perform other system tasks. In this case, the system must start at the beginning of the algorithm when it returns to determine the status of the operation (top of Figure 6).



Note: The system should recheck the toggle bit even if DQ5 = "1" because the toggle bit may stop toggling as DQ5 changes to "1." See the subsections on DQ6 and DQ2 for more information.

Figure 6. Toggle Bit Algorithm

#### **DQ5: Exceeded Timing Limits**

DQ5 indicates whether the program or erase time has exceeded a specified internal pulse count limit. Under these conditions DQ5 produces a "1," indicating that the program or erase cycle was not successfully completed.

The device may output a "1" on DQ5 if the system tries to program a "1" to a location that was previously programmed to "0." Only an erase operation can change a "0" back to a "1." Under this condition, the device halts the operation, and when the timing limit has been exceeded, DQ5 produces a "1".

Under both these conditions, the system must write the reset command to return to reading array data (or to the erase-suspend-read mode if a bank was previously in the erase-suspend-program mode).

#### **DQ3: Sector Erase Timer**

After writing a sector erase command sequence, the system may read DQ3 to determine whether or not erasure has begun. (The sector erase timer does not apply to the chip erase command.) If additional sectors are selected for erasure, the entire time-out also applies after each additional sector erase command. When the time-out period is complete, DQ3 switches from a "0" to a "1". If the system can guarantee the time between additional sector erase commands to be less than 50 µs, it need not monitor DQ3. See also the Sector Erase Command Sequence section.

After the sector erase command is written, the system should read the status of DQ7 (Data# Polling) or DQ6 (Toggle Bit I) to ensure that the device has accepted the command sequence, and then read DQ3. If DQ3 is "1", the Embedded Erase algorithm has begun; all further commands (except Erase Suspend) are ignored until the erase operation is complete. If DQ3 is "0", the device will accept additional sector erase commands. To ensure the command has been accepted, the system software should check the status of DQ3 prior to and following each subsequent sector erase command. If DQ3 is high on the second status check, the last command might not have been accepted.

Table 6 shows the status of DQ3 relative to the other status bits.

Table 6. Write Operation Status

	Status		DQ7 (Note 2)	DQ6	DQ5 (Note 1)	DQ3	DQ2 (Note 2)	RY/BY#
Standard	Embedded Progr	am Algorithm	DQ7#	Toggle	0	N/A	No toggle	0
Mode	Embedded Erase	Algorithm	0	Toggle	0	1	Toggle	0
	Erase-Suspend-	Erase Suspended Sector	1	No toggle	0	N/A	Toggle	1
	Read	Non-Erase Suspended Sector	Data	Data	Data	Data	Data	1
	Erase-Suspend-Program		DQ7#	Toggle	0	N/A	N/A	0

- 1. DQ5 switches to '1' when an Embedded Program or Embedded Erase operation has exceeded the maximum timing limits. Refer to the section on DQ5 for more information.
- 2. DQ7 and DQ2 require a valid address when reading status information. Refer to the appropriate subsection for further details.
- 3. When reading write operation status bits, the system must always provide the bank address where the Embedded Algorithm is in progress. The device outputs array data if the system addresses a non-busy bank.

Notes:

#### **ABSOLUTE MAXIMUM RATINGS**

Storage Temperature Plastic Packages65°C to +150°C
Ambient Temperature with Power Applied65°C to +125°C
Voltage with Respect to Ground
V <sub>CC</sub> (Note 1)0.5 V to +4.0 V A9, OE#,
and RESET# (Note 2)0.5 V to +12.5 V
All other pins (Note 1)
Output Short Circuit Current (Note 3) 200 mA

- Minimum DC voltage on input or I/O pins is --0.5 V. During voltage transitions, input or I/O pins may undershoot V<sub>SS</sub> to --2.0 V for periods of up to 20 ns. Maximum DC voltage on input or I/O pins is V<sub>CC</sub> +0.5 V. See Figure 7. During voltage transitions, input or I/O pins may overshoot to V<sub>CC</sub> +2.0 V for periods up to 20 ns. See Figure 8.
- Minimum DC input voltage on pins A9, OE#, and RESET# is -0.5 V. During voltage transitions, A9, OE#, and RESET# may undershoot V<sub>SS</sub> to -2.0 V for periods of up to 20 ns. See Figure 7. Maximum DC input voltage on pin A9 is +12.5 V which may overshoot to 14.0 V for periods up to 20 ns.
- No more than one output may be shorted to ground at a time. Duration of the short circuit should not be greater than one second.

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this data sheet is not implied. Exposure of the device to absolute maximum rating conditions for extended periods may affect device reliability.

#### **OPERATING RANGES**

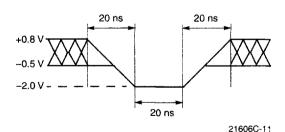


Figure 7. Maximum Negative Overshoot Waveform

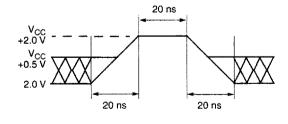


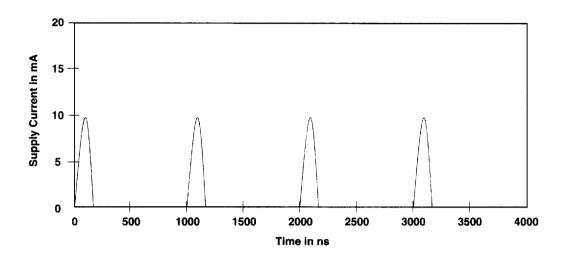
Figure 8. Maximum Positive
Overshoot WaveformOperating Ranges

# DC CHARACTERISTICS CMOS Compatible

Parameter Symbol	Parameter Description	Test Conditions		Min	Тур	Max	Unit
l <sub>LI</sub>	Input Load Current	$V_{IN} = V_{SS}$ to $V_{CC}$ , $V_{CC} = V_{CC \text{ max}}$				±1.0	μA
I <sub>LIT</sub>	A9 Input Load Current	V <sub>CC</sub> = V <sub>CC max</sub> ; A9 = 12	2.5 V			35	μA
I <sub>LO</sub>	Output Leakage Current	$V_{OUT} = V_{SS}$ to $V_{CC}$ , $V_{CC} = V_{CC max}$				±1.0	μΑ
		CE# = V <sub>IL</sub> OE# = V <sub>IH</sub> ,	5 MHz		7	12	
	V <sub>CC</sub> Active Read Current	Byte Mode	1 MHz		2	4	mA
I <sub>CC1</sub>	(Note 1)	CE# = V <sub>IL,</sub> OE# = V <sub>IH</sub> ,	5 MHz		7	12	] ""
		Word Mode	1 MHz		2	4	
I <sub>CC2</sub>	V <sub>CC</sub> Active Write Current (Note 2)	CE# = V <sub>IL,</sub> OE# = V <sub>IH</sub> , \		15	30	mA	
Іссз	V <sub>CC</sub> Standby Current (CE# Controlled)	V <sub>CC</sub> = V <sub>CC max</sub> ; OE# = CE#, RESET# = V <sub>CC</sub> ±		0.2	5	μA	
I <sub>CC4</sub>	V <sub>CC</sub> Reset Current (RESET# Controlled)	V <sub>CC</sub> = V <sub>CC max</sub> ; RESET# = V <sub>SS</sub> ± 0.3 V		0.2	5	μA	
I <sub>CC5</sub>	Automatic Sleep Mode (Note 3)	$V_{IH} = V_{CC} \pm 0.3 \text{ V};$ $V_{IL} = V_{SS} \pm 0.3 \text{ V}$		0.2	5	μА	
	V <sub>CC</sub> Active Read-While-	CE# = VIL.	Byte		21	45	mA
I <sub>CC6</sub>	Program Current (Notes 1, 4)	OE# = VIH	Word		21	45	1117
	V <sub>CC</sub> Active Read-While-Erase	CE# = V <sub>IL</sub>	Byte		21	45	mA
I <sub>CC7</sub>	Current (Notes 1, 4)	OE# <sub>=</sub> V <sub>IH</sub>	Word		21	45	1110
I <sub>CC8</sub>	V <sub>CC</sub> Active Program-While- Erase-Suspended Current (Note 4)	CE# = V <sub>IL</sub> , OE# <sub>=</sub> V <sub>IH</sub>			17	35	mA
V <sub>IL</sub>	Input Low Voltage			0.5		0.8	V
V <sub>IH</sub>	Input High Voltage			0.7 x V <sub>CC</sub>		V <sub>CC</sub> + 0.3	V
V <sub>ID</sub>	Voltage for Autoselect and Temporary Sector Unprotect	V <sub>CC</sub> = 3.0 V ± 10%		11.5		12.5	ν
V <sub>OL</sub>	Output Low Voltage	I <sub>OL</sub> = 4.0 mA, V <sub>CC</sub> = V <sub>CC min</sub>				0.45	V
V <sub>OH1</sub>	0.4-411-63/5/5-5-	$I_{OH} = -2.0 \text{ mA}, V_{CC} = 1$	CC min	0.85 V <sub>CC</sub>			V
V <sub>OH2</sub>	Output High Voltage	I <sub>OH</sub> = -100 μA, V <sub>CC</sub> = 1	CC min	V <sub>CC</sub> -0.4			
V <sub>LKO</sub>	Low V <sub>CC</sub> Lock-Out Voltage (Note 4)			2.3		2.5	٧

- 1. The  $I_{CC}$  current listed is typically less than 2 mA/MHz, with OE# at  $V_{IH}$
- 2.  $I_{CC}$  active while Embedded Erase or Embedded Program is in progress.
- Automatic sleep mode enables the low power mode when addresses remain stable for t<sub>ACC</sub> + 30 ns. Typical sleep mode current is 200 nA.
- 4. Not 100% tested.

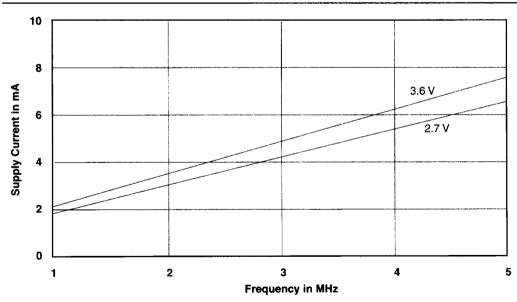
## Zero-Power Flash



Note: Addresses are switching at 1 MHz

21606C-13

Figure 9. I<sub>CC1</sub> Current vs. Time (Showing Active and Automatic Sleep Currents)



Note: T = 25 °C

Figure 10. Typical I<sub>CC1</sub> vs. Frequency

#### **TEST CONDITIONS**

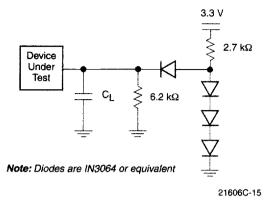


Figure 11. Test Setup

Table 7. Test Specifications

Test Condition	-70, -80	All others	Unit	
Output Load	1	TTL gate	<del></del>	
Output Load Capacitance, C <sub>L</sub> (including jig capacitance)	30	100	рF	
Input Rise and Fall Times	5	5	ns	
Input Pulse Levels	0.0-	-3.0	V	
Input timing measurement reference levels	1.	5	٧	
Output timing measurement reference levels	1.	1.5		

#### **KEY TO SWITCHING WAVEFORMS**

WAVEFORM	INPUTS	OUTPUTS
		Steady
	Ch	anging from H to L
	Ch	anging from L to H
XXXXX	Don't Care, Any Change Permitted	Changing, State Unknown
<del>∑) (</del> ((	Does Not Apply	Center Line is High Impedance State (High Z)

KS000010-PAL

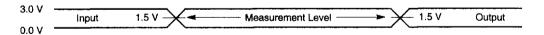
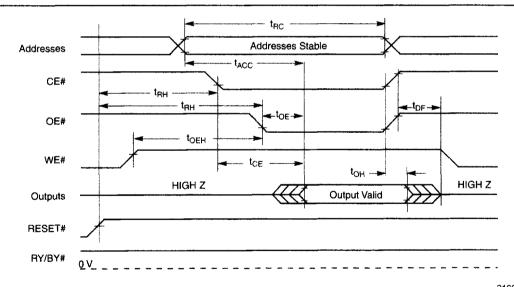


Figure 12. Input Waveforms and Measurement Levels

## **Read-Only Operations**

Paran	neter						Speed	Options	1	
JEDEC	Std	Description		Test Setup		-70	-80	-90	-120	Unit
t <sub>AVAV</sub>	t <sub>RC</sub>	Read Cycle Time (No	ote 1)		Min	70	80	80	120	ns
t <sub>AVQV</sub>	tACC	Address to Output De	elay	CE#, OE# = V <sub>IL</sub>	Max	70	80	80	120	ns
t <sub>ELQV</sub>	t <sub>CE</sub>	Chip Enable to Outpu	ıt Delay	OE# = V <sub>IL</sub>	Max	70	80	80	120	ns
t <sub>GLQV</sub>	t <sub>OE</sub>	Output Enable to Out	put Delay		Max	30	30	35	50	ns
t <sub>EHQZ</sub>	t <sub>DF</sub>	Chip Enable to Outpu	ut High Z (Note 1)		Max	25	25	30	30	ns
t <sub>GHQZ</sub>	t <sub>DF</sub>	Output Enable to Out	put High Z (Note 1)		Max	25	25	30	30	ns
t <sub>AXQX</sub>	tон	Output Hold Time Fro OE#, Whichever Occ	om Addresses, CE# or urs First		Min		(	)		ns
			Read		Min	0				ns
l locu	Output Enable Hold Time (Note 1)	Toggle and Data# Polling		Min		1	0	***	ns	

- 1. Not 100% tested.
- 2. See Figure 11 and Table 7 for test specifications.



21606C-17
Figure 13. Read Operation Timings

## Hardware Reset (RESET#)

Paran	neter				
JEDEC	Std	Description	V Abrilland	All Speed Options	Unit
	t <sub>Ready</sub>	RESET# Pin Low (During Embedded Algorithms) to Read Mode (See Note)			μs
	t <sub>Ready</sub>	RESET# Pin Low (NOT During Embedded Algorithms) to Read Mode (See Note)	Max	500	ns
	t <sub>RP</sub>	RESET# Pulse Width	Min	500	ns
	t <sub>RH</sub>	Reset High Time Before Read (See Note)	Min	50	ns
**	t <sub>RPD</sub>	RESET# Low to Standby Mode	Min	20	μs
	t <sub>RB</sub>	RY/BY# Recovery Time	Min	0	ns

Note: Not 100% tested.

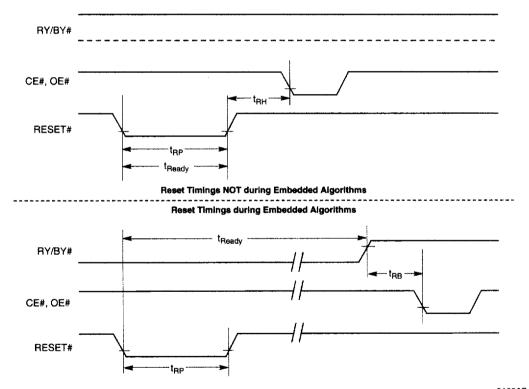


Figure 14. Reset Timings

# AC CHARACTERISTICS Word/Byte Configuration (BYTE#)

Para	ameter					-80 -90 -120		
JEDEC	Std	Description		-70	-80		-120	Unit
	telel/teleh	CE# to BYTE# Switching Low or High	Max					ns
	† <sub>FLQZ</sub>	BYTE# Switching Low to Output HIGH Z	Max	25	25	30	30	ns
	t <sub>FHQV</sub>	BYTE# Switching High to Output Active	Min	70	80	90	120	ns

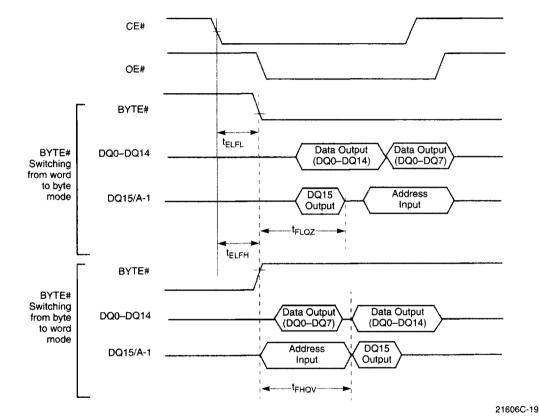
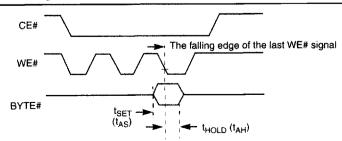


Figure 15. BYTE# Timings for Read Operations



**Note:** Refer to the Erase/Program Operations table for  $t_{AS}$  and  $t_{AH}$  specifications.

21606C-20

Figure 16. BYTE# Timings for Write Operations

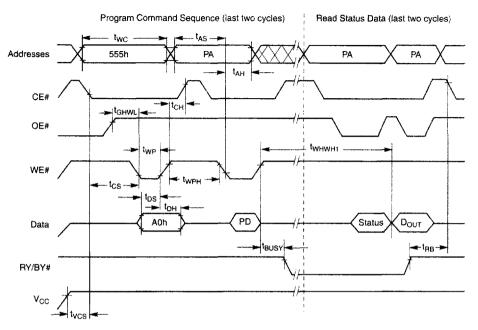
30

## **Erase and Program Operations**

Paran	neter								
JEDEC	Std	Description			-70	-80	-90	-120	Unit
t <sub>AVAV</sub>	twc	Write Cycle Time (Note 1)		Min	70	80	90	120	ns
t <sub>AVWL</sub>	t <sub>AS</sub>	Address Setup Time		Min		0	,		ns
	taso	Address Setup Time to OE# low during to	ggle bit polling	Min	45	45	45	50	ns
t <sub>WLAX</sub>	t <sub>AH</sub>	Address Hold Time		Min	45	45 45 50			ns
	t <sub>AHT</sub>	Address Hold Time From CE# or OE# hiduring toggle bit polling	gh	Min		0	<u> </u>	<del></del>	ns
t <sub>DVWH</sub>	t <sub>DS</sub>	Data Setup Time		Min	35	35	45	50	ns
twHDX	† <sub>DH</sub>	Data Hold Time		Min		0			ns
	t <sub>OEPH</sub>	Output Enable High during toggle bit pol	tput Enable High during toggle bit polling		20	20	20	25	ns
<sup>t</sup> GHWL	<sup>†</sup> GHWL	Read Recovery Time Before Write (OE# High to WE# Low)		Min		0			ns
t <sub>ELWL</sub>	t <sub>CS</sub>	CE# Setup Time		Min		0			ns
t <sub>WHEH</sub>	t <sub>CH</sub>	CE# Hold Time		Min		0			ns
twLWH	t <sub>WP</sub>	Write Pulse Width		Min	35	35	35	50	ns
twHDL	t <sub>WPH</sub>	Write Pulse Width High		Min		30	)		ns
	t <sub>SR/W</sub>	Zero Latency Between Read and Write 0	Operations	Min		0	7.22.		ns
			Byte	Тур		9			
twhwh1	t <sub>WHWH1</sub>	Programming Operation (Note 2)	Word	Тур		11			μs
t <sub>WHWH2</sub>	twhwh2	Sector Erase Operation (Note 2)		Тур		0.7	7		sec
•	tvcs	V <sub>CC</sub> Setup Time (Note 1)		Min		50	)		μs
	t <sub>RB</sub>	Write Recovery Time from RY/BY#		Min		0		,	ns
	t <sub>BUSY</sub>	Program/Erase Valid to RY/BY# Delay		Min		90	)		ns

<sup>1.</sup> Not 100% tested.

<sup>2.</sup> See the "Erase and Programming Performance" section for more information.

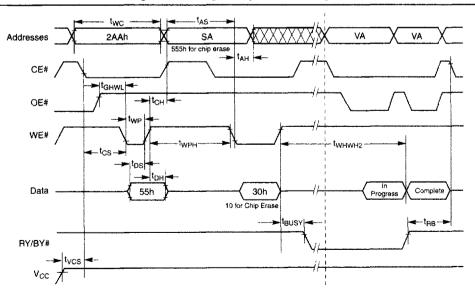


#### Notes:

- 1.  $PA = program \ address, PD = program \ data, D_{OUT}$  is the true data at the program address.
- 2. Illustration shows device in word mode.

21606C-21

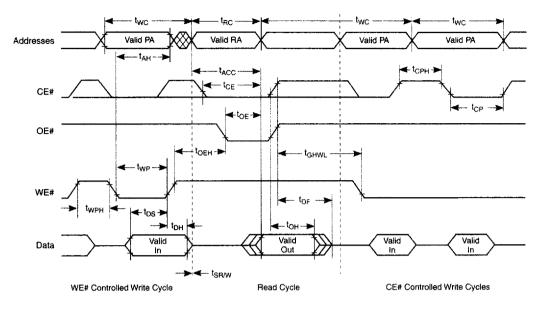
Figure 17. Program Operation Timings



#### Notes:

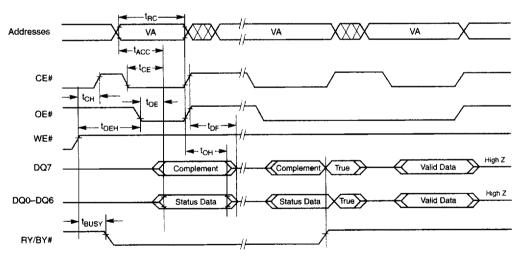
- 1. SA = sector address (for Sector Erase), VA = Valid Address for reading status data (see "Write Operation Status").
- 2. Illustration shows device in word mode.

Figure 18. Chip/Sector Erase Operation Timings



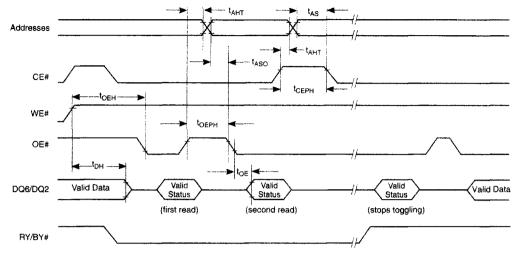
21606C-23

Figure 19. Back-to-Back Read/Write Cycle Timings



Note: VA = Valid address. Illustration shows first status cycle after command sequence, last status read cycle, and array data read cycle.

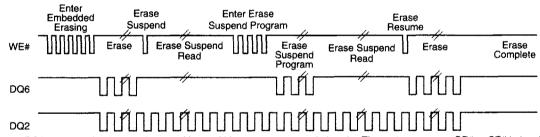
Figure 20. Data# Polling Timings (During Embedded Algorithms)



Note: VA = Valid address; not required for DQ6. Illustration shows first two status cycle after command sequence, last status read cycle, and array data read cycle

21606C-25

Figure 21. Toggle Bit Timings (During Embedded Algorithms)



**Note:** DQ2 toggles only when read at an address within an erase-suspended sector. The system may use OE# or CE# to toggle DQ2 and DQ6.

Figure 22. DQ2 vs. DQ6

## **Temporary Sector Unprotect**

Param	eter				
JEDEC	Std	Description		All Speed Options	Unit
	tvida	V <sub>ID</sub> Rise and Fall Time (See Note)	Min	500	ns
	tase	RESET# Setup Time for Temporary Sector Unprotect	Min	4	μs
	t <sub>RRB</sub>	RESET# Hold Time from RY/BY# High for Temporary Sector Unprotect	Min	4	μs

Note: Not 100% tested.

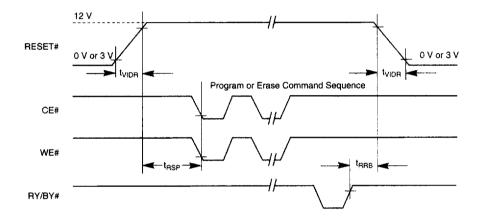


Figure 23. Temporary Sector Unprotect Timing Diagram

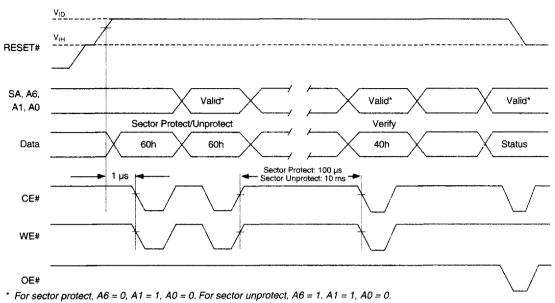


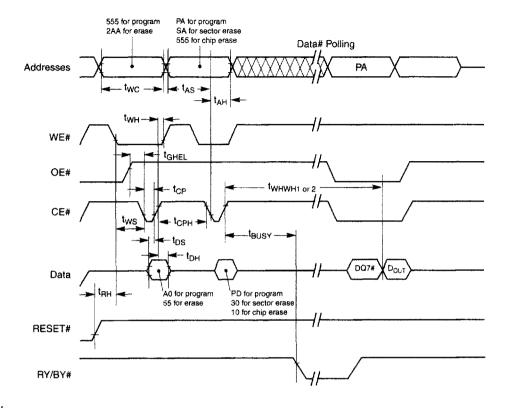
Figure 24. Sector Protect/Unprotect Timing Diagram

## Alternate CE# Controlled Erase/Program Operations

Para	neter								
JEDEC	Std	Description			-70	-80	-90	-120	Unit
t <sub>AVAV</sub>	twc	Write Cycle Time (Note 1)		Min	70	80	90	120	ns
t <sub>AVWL</sub>	t <sub>AS</sub>	Address Setup Time		Min	0			•	ns
tELAX	t <sub>AH</sub>	Address Hold Time		Min	45	45	45	50	ns
t <sub>DVEH</sub>	t <sub>DS</sub>	Data Setup Time	Setup Time		35	35	45	50	ns
t <sub>EHDX</sub>	t <sub>DH</sub>	ata Hold Time		Min		0		ns	
<sup>t</sup> GHEL	<sup>†</sup> GHEL	Read Recovery Time Before Write (OE# High to WE# Low)		Min		0	i	ns	
twlel	tws	WE# Setup Time		Min		0			ns
t <sub>EHWH</sub>	t <sub>WH</sub>	WE# Hold Time		Min		0			ns
tELEH	t <sub>CP</sub>	CE# Pulse Width		Min	35	35	35	50	ns
t <sub>EHEL</sub>	t <sub>CPH</sub>	CE# Pulse Width High		Min		30	)		ns
		0 4 4 6	Byte	Тур	9				
<sup>1</sup> WHWH1	t <sub>WHWH1</sub>	Programming Operation (Note 2)	Word	Тур		1	ı		μs
t <sub>WHWH2</sub>	t <sub>WHWH2</sub>	Sector Erase Operation (Note 2)	Sector Erase Operation (Note 2)			0.	7		sec

<sup>1.</sup> Not 100% tested.

<sup>2.</sup> See the "Erase and Programming Performance" section for more information.



#### Notes:

- 1. Figure indicates last two bus cycles of a program or erase operation.
- PA = program address, SA = sector address, PD = program data. DQ7# = complement of the data written to the device.
   D<sub>OUT</sub> = data written to the device.
- 3. Waveforms are for the word mode.

Figure 25. Alternate CE# Controlled Erase/Program Operation Timings

#### **ERASE AND PROGRAMMING PERFORMANCE**

Parameter		Typ (Note 1)	Max (Note 2)	Unit	Comments		
Sector Erase Time Chip Erase Time		Sector Erase Time		0.7	15 sec		Excludes 00h programming
		10		sec	prior to erasure (Note 4)		
Byte Program Time		9	300	μs			
Word Program Time	Word Program Time		360	μs	Excludes system level		
Chip Program Time (Note 3)	Byte Mode	4.5	13.5		overhead (Note 5)		
	Word Mode	2.9	8.7	sec			

#### Notes:

- Typical program and erase times assume the following conditions: 25°C, 3.0 V V<sub>CC</sub>, 1,000,000 cycles. Additionally, programming typicals assume checkerboard pattern.
- 2. Under worst case conditions of 90°C, V<sub>CC</sub> = 2.7 V, 1,000,000 cycles.
- 3. The typical chip programming time is considerably less than the maximum chip programming time listed, since most bytes program faster than the maximum program times listed.
- 4. In the pre-programming step of the Embedded Erase algorithm, all bytes are programmed to 00h before erasure.
- System-level overhead is the time required to execute the two- or four-bus-cycle sequence for the program command. See Table 5 for further information on command definitions.
- 6. The device has a guaranteed minimum erase and program cycle endurance of 1,000,000 cycles.

#### LATCHUP CHARACTERISTICS

	Min	Max
Input voltage with respect to V <sub>SS</sub> on all pins except I/O pins (including A9, OE#, and RESET#)	-1.0 V	12.5 V
Input voltage with respect to V <sub>SS</sub> on all I/O pins	-1.0 V	V <sub>CC</sub> + 1.0 V
V <sub>CC</sub> Current	-100 mA	+100 mA

Includes all pins except  $V_{CC}$ . Test conditions:  $V_{CC} = 3.0 \text{ V}$ , one pin at a time.

#### TSOP AND SO PIN CAPACITANCE

Parameter Symbol	Parameter Description	Test Setup	Тур	Max	Unit
C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> = 0	6	7.5	pF
C <sub>OUT</sub>	Output Capacitance	V <sub>OUT</sub> = 0	8.5	12	рF
C <sub>IN2</sub>	Control Pin Capacitance	V <sub>IN</sub> = 0	7.5	9	pF

#### Notes:

- 1. Sampled, not 100% tested.
- Test conditions T<sub>A</sub> ≈ 25°C, f = 1.0 MHz.

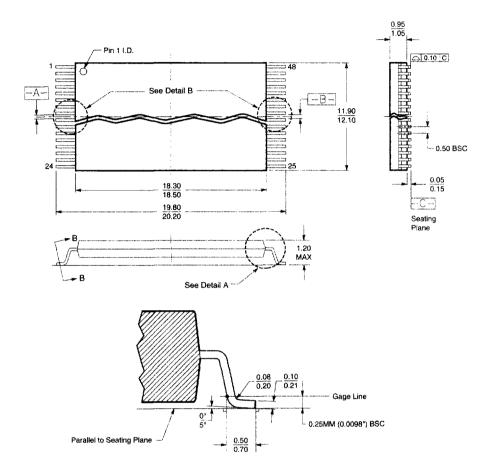
#### **DATA RETENTION**

Parameter Description	Test Conditions	Min	Unit
Minimum Pattern Data Retention Time	150°C	10	Years
	125°C	20	Years

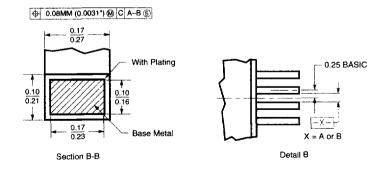
## **PHYSICAL DIMENSIONS**

## TS 048

## 48-Pin Standard TSOP (measured in millimeters)

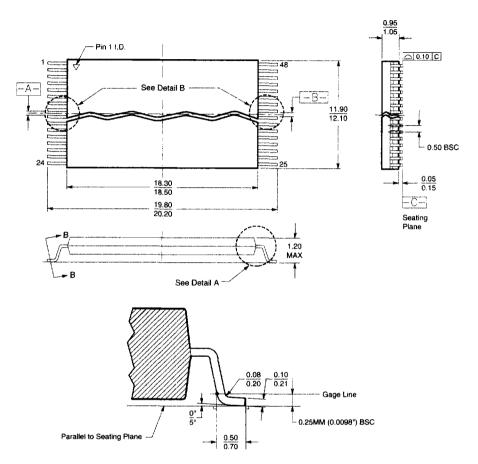


Detail A

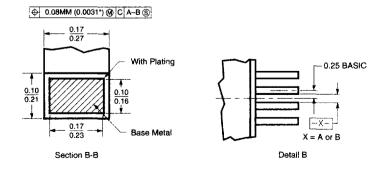


16-038-TSOP-2\_AB TS 048 EC98 5-14-98 lv

# PHYSICAL DIMENSIONS (continued) TSR048 48-Pin Reverse TSOP (measured in millimeters)



Detail A

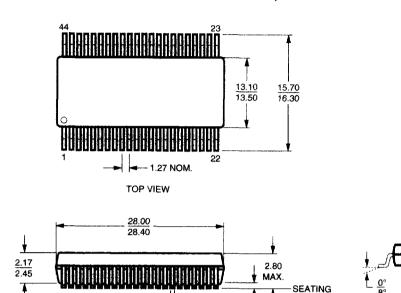


16-038-TSOP-2\_AB TSR048 EC98 5-14-98 lv

## **PHYSICAL DIMENSIONS (continued)**

## SO 044

## 44-Pin Small Outline (measured in millimeters)



PLANE

0.60 1.00

#### **REVISION SUMMARY**

#### Revision B

Expanded data sheet from Advance Information to Preliminary version.

#### **Revision C**

#### Global

Changed -70R speed option to -70.

# Figure 1, In-system Sector Protect/Unprotect Algorithm

Added "PSLSCNT=1" to sector protect algorithm.

#### Reset Command

Deleted last paragraph; applies only to hardware reset.

#### DQ6: Toggle Bit I

First and second para., clarified that the toggle bit may be read "at any address within the programming or erasing bank," not at "any address." Fourth para., clarified "device" to "bank"

#### **Operating Ranges**

Deleted reference to regulated voltage range

#### **DC Characteristics**

Added Note 4 reference to I<sub>CC6</sub> and I<sub>CC7</sub>.

#### **Erase and Program Operations**

Corrected note references for  $t_{WHWH1},\,t_{WHWH2},\,\text{and}\,t_{VCS}$ 

#### **Temporary Sector Unprotect**

Added note reference to tylDR-

# Figure 24, Sector Protect/Unprotect Timing Diagram

Updated figure to correct address waveform—valid address not required in first cycle.

# Alternate CE# Controlled Erase/Program Operations

Corrected note references for twhwh1, twhwh2

#### **Erase and Programming Performance**

In Note 2, changed worst case endurance to 1 million cycles.

#### Trademarks

Copyright © 1998 Advanced Micro Devices, Inc. All rights reserved.

AMD, the AMD logo, and combinations thereof are registered trademarks of Advanced Micro Devices, Inc.

ExpressFlash is a trademark of Advanced Micro Devices, Inc.

Product names used in this publication are for identification purposes only and may be trademarks of their respective companies.

#### Sales Offices

#### North American

North American		
		(205) 830-9192
ARIZONA	****	(602) 242-4400
CALIFORNIA,		
Calabasas		(818) 878-9988
Sacramento /Roseville		(714) 450-7500 (916) 786-6700
San Diego	<b></b>	(619) 560-7030
San Jose		(408) 922-0300
COLORADO		(303) 741-2900
CONNECTICUT		(203) 264-7800
FLORIDA,		(040) 500 0074
Miami	****************	(813) 530-9971
GEORGIA	*********************	(305) 264-2572 (770) 449-7920
ILLINOIS, Chicago (Itasc:	a)	(708) 773-4422
KENTUCKY	***************************************	(606) 224-1353 (410) 381-3790
MARYLAND		(410) 381-3790
MASSACHUSETTS	********	(617) 273-3970
MINNESOTA NEW JERSEY,	***********	(612) 938-0001
		(609) 662-2900
Parsippany	***************************************	(201) 299-0002
NEW YORK.		
		(914) 279-8323
Rochester		(716) 425-8050
NORTH CAROLINA		(919) 878-8111
TEXAS,	***************************************	(503) 245-0080
Austin		(512) 346-7830
Dallas		(214) 934-9099
Houston	************	(713) 376-8084
1 1944001 10,		
	i	
South American		
South American		55-11-55055267
South American		55-11-55055267
South American BRAZIL International		
South American BRAZIL International AUSTRALIA, N Sydney	TEL FAX	(61) 2-9959-1397
South American BRAZIL International AUSTRALIA, N Sydney. BELGIUM, Antwerpen.	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA,	TEL FAX TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beiling	TEL FAX TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8610) 6051-3815
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanahai	TEL FAX TEL FAX TEL TEL FAX TEL	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8610) 6051-3815 (8621) 6350-0837
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing. Shanghai	TEL FAX TEL FAX TEL FAX TEL FAX TEL TEL TEL	(61) 2-9959-1397 (61) 2-9959-1037 (61) 2-9959-1037 32-3-248-46-42 (8610) 6501-1566 (8610) 6051-3815 (8621) 6350-0837 (8621) 6350-0838
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai	TEL FAX TEL FAX TEL	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8621) 6350-0838 (8621) 6350-0838 (8621) 3550-0848 (358) 9 881 3117
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai	TEL FAX TEL FAX TEL	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8621) 6350-0838 (8621) 6350-0838 (8621) 3550-0848 (358) 9 881 3117
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Hetsinki FRANCE, Paris	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8610) 6051-3815 (8621) 6350-0837 (8621) 6350-0838 (8621) 3650-0840 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Hetsinki	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8610) 6051-3815 (8621) 6350-0837 (8621) 6350-0838 (8621) 3650-0840 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Helsinki FRANCE, Paris	TEL FAX TEL FAX TEL FAX TEL FAX TEL FAX FAX FAX FAX FAX FAX TEL FAX FAX FAX FAX TEL FAX FAX	(61) 2-9959-1397 (61) 2-9959-1037 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8610) 6051-3815 (8621) 6350-0838 (8621) 6350-0838 (8621) 6350-0844 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghal FINLAND, Helsinki FRANCE, Paris GERMANY, Bad Homburg	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-46-42 (8610) 6501-1566 (8610) 6051-3815 (8621) 6350-0836 (8621) 6350-0846 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1013
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Hetsinki FRANCE, Paris GERMANY, Bad Homburg	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6051-1566 (8610) 6051-3815 (8621) 6350-0839 (8621) 3650-0840 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1013 49-6172-92670 49-6172-23195
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Helsinki FRANCE, Paris GERMANY, Bad Homburg München	TEL FAX TEL	(61) 2-9959-1397 (61) 2-9959-1037 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8610) 6051-3815 (8621) 6350-0837 (8621) 6350-0837 (8621) 6350-0847 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1013 349-6172-92676 49-6172-23195
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Helsinki FRANCE, Paris GERMANY, Bad Homburg München	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (62) 2-248-45-42 (8610) 8501-1566 (8610) 8550-0837 (8621) 8350-0838 (8621) 8350-0838 (358) 9 804 1110 (358) 9 804 1110 (33-1-49-75-1010 (33-1-49-75-1010 (49-81-75-23198 (49-89-405430 (49-89-405430 (49-89-405430 (49-89-405830 (49-89-405830
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghal FINLAND, Helsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1397 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (861) 6501-1566 (861) 6550-0837 (8621) 6350-0838 (8621) 6350-0838 (8621) 6350-0838 (8621) 6350-0838 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1010 49-6172-23195 49-89-406490 (852) 2956-0388 (852) 2956-0588
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghal FINLAND, Helsinki FRANCE, Paris GERIMANY, Bad Homburg München HONG KONG, Kowloon	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1397 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (861) 6501-1566 (861) 6550-0837 (8621) 6350-0838 (8621) 6350-0838 (8621) 6350-0838 (8621) 6350-0838 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1010 49-6172-23195 49-89-406490 (852) 2956-0388 (852) 2956-0588
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Hetsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1397 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (61) 2-9959-1037 (861) 6501-1566 (861) 6550-0837 (8621) 6350-0838 (8621) 6350-0838 (8621) 6350-0838 (8621) 6350-0838 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1010 49-6172-23195 49-89-406490 (852) 2956-0388 (852) 2956-0588
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Helsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano JAPAN,	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 8501-1566 (8610) 8051-3815 (8621) 6350-0838 (8621) 6350-0838 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1010 49-6172-23195 49-89-45053 49-89-45053 (852) 2956-0386 (852) 2956-0586 39-2-381961
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghal FINLAND, Helsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano JAPAN, Osaka	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-46-42 (8610) 6501-1566 (8610) 6501-3815 (8621) 6350-0837 (8621) 6350-0836 (8621) 3650-0844 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1010 49-6172-92677 49-6172-23195 49-89-450530 (852) 2956-0386 (852) 2956-0386 (852) 2956-0386 (852) 2956-0386 (852) 2956-0386
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Hetsinki FRANCE, Paris GERIMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano JAPAN, Osaka	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8610) 6551-3815 (8621) 6350-0839 (8621) 3650-0840 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1013 49-6172-23195 49-89-450530 49-89-406495 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Helsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano JAPAN, Osaka	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 8501-1566 (8610) 8501-1566 (8610) 850-0837 (8621) 6350-0838 (8621) 6350-0838 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1010 33-1-49-75-1010 49-6172-23195 49-89-450530 (852) 2956-0388 (852) 2956-0588 39-2-381961 39-2-381961 39-2-38193458 81-6-243-3255 81-6-243-3255
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Hetsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano JAPAN, Osaka Tokyo	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-46-42 (8610) 6501-1566 (8610) 6551-3815 (8621) 6350-0837 (8621) 6350-0837 (8621) 6350-0837 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1013 49-6172-22670 49-6172-23195 49-89-450530 (952) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Hetsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano JAPAN, Csaka Tokyo KOREA, Seoul	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-46-42 (8610) 6501-1566 (8610) 6501-3815 (8621) 6350-0837 (8621) 6350-0836 (8621) 6350-0846 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1010 33-1-49-75-1010 49-6172-22195 49-89-450530 (852) 2956-0386 (852) 2956-0386 (852) 2956-0386 (852) 2956-0386 (852) 392-381904 392-381904 81-6-243-3250 81-3-3346-7600 81-3-3342-5197 (82) 2784-0034
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Hetsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano JAPAN, Osaka Tokyo KOREA, Seoul	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1037 32-3-248-46-42 (6610) 6501-1566 (8610) 6501-1566 (8610) 6501-3815 (8621) 6350-0839 (8621) 6350-0839 (8621) 3655-0849 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1010 49-6172-23195 49-89-450530 (852) 2956-0588 (852) 2956-0588 (852) 2956-0588 (852) 2956-0588 (852) 2956-0588 (852) 2956-0588 (853) 39-2-381961 39-2-38103458 81-6-243-3250 81-3-3346-7600 81-3-3346-7600 81-3-3346-7509 (82) 2784-0030 (82) 2784-0030 (82) 2784-0030 (82) 2784-0030 (82) 2784-0030
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Hetsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano JAPAN, Csaka Tokyo KOREA, Seoul SINGAPORE, Singapore	TEL FAX	(61) 2-9959-1397 (61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8610) 6551-3815 (8621) 6350-0839 (8621) 36550-0849 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1013 49-6172-22195 49-89-450530 49-89-450530 49-89-450530 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 39-2-381961 39-2-381961 39-2-381961 39-2-381961 682) 2784-0030 (62) 2784-0030 (62) 2784-0030 (62) 2784-0034 (655) 337-7033 (655) 338-1611
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Helsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano JAPAN, Osaka Tokyo KOREA, Seoul SINGAPORE, Singapore SCOTLAND, Stirling	TEL FAX TEL	(61) 2-9959-1397 (61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8610) 6501-3815 (8621) 6350-0838 (8621) 6350-0838 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1010 33-1-49-75-1013 49-6172-23195 49-89-450530 49-89-405490 (852) 2956-0588 39-2-381961 39-2-381961 39-2-38103458 81-6-243-3253 81-3-343-7600 81-3-3342-5197 (82) 2784-8014 (65) 338-1611 (65) 338-1611 (65) 338-1611
South American BRAZIL International AUSTRALIA, N Sydney BELGIUM, Antwerpen CHINA, Beijing Shanghai FINLAND, Helsinki FRANCE, Paris GERMANY, Bad Homburg München HONG KONG, Kowloon ITALY, Milano JAPAN, Osaka Tokyo KOREA, Seoul SINGAPORE, Singapore SCOTLAND, Stirling	TEL FAX TEL	(61) 2-9959-1397 (61) 2-9959-1397 (61) 2-9959-1037 32-3-248-43-00 32-3-248-46-42 (8610) 6501-1566 (8610) 6551-3815 (8621) 6350-0839 (8621) 36550-0849 (358) 9 881 3117 (358) 9 804 1110 33-1-49-75-1013 49-6172-22195 49-89-450530 49-89-450530 49-89-450530 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 (852) 2956-0388 39-2-381961 39-2-381961 39-2-381961 39-2-381961 682) 2784-0030 (62) 2784-0030 (62) 2784-0030 (62) 2784-0034 (655) 337-7033 (655) 338-1611

SWITZERLAND, Geneva	TEL	(41) 22-788-0251
		(41) 22-788-0617
SWEDEN,		(11,7 == 120 == 11
Stockholm area	TEL	(46) 8629-2850
		(46) 898-0906
TAIWAN, Taipei		
		(886) 2712-2182
UNITED KINGDOM.		,,
London area	TEL	(44) 1276-803100
		(44) 1276-803102
		(44) 1925-830380
		(44) 1925-830204
North American I	Zanraean:	totivae

#### North American Representatives

North American riepresentative	3
ARIZONA.	
Scottsdale - THORSON DESERT STATES	(602) 998-2444
CALIFORNIA,	•
San Ysidro - SOLANO ELECTRONICA	(619) 428-8362
CANADA,	, ,
Burnaby, B.C. – DAVETEK MARKETING	
Clagary, Alberta - DAVETEK MARKETING	
Kanata, Ontario - J-SQUARED TECH	
Mississauga, Ontario - J-SQUARED TECH	
St Laurent, Quebec - J-SQUARED TECH	(514) 747-1211
ILLINOIS,	
Skokie - INDUSTRIAL REPS, INC.	(708) 967-8430
INDIANA,	10.17 AFT 70.11
Kokomo - SCHILLINGER ASSOC	(317) 457-7241
IOWA,	(040) 004 4000
Cedar Rapids - LORENZ SALESKANSAS.	(319) 294-1000
Overland Park - LORENZ SALES	(012) 400 1212
MEXICO.	(913) 409-1312
Guadalajara – LATINREP	(522) 647-4250
Mexico City - LATINREP	
Monterrey - LATINREP	
MICHIGAN.	(020) 501 2020
Brighton - COM-TEK SALES, INC	. (810) 227-0007
Holland - COM-TEK SALES, INC	(616) 335-8418
MINNESOTA.	. (,
Edina - MEL FOSTER COMPANY	(612) 941-9790
Winona - MEL FOSTER COMPANY	(507) 457-3389
MISSOURI,	
St Louis - LORENZ SALES	(314) 997-4558
NEBRASKA,	
Lincoln - LORENZ SALES	(402) 475-4660
NEW YORK,	
Plainview - Component Consultants	
East Syracuse - NYCOM	
Fairport - NYCOM	(716) 425-5120
OHIO,	(540) 400 6776
Centerville - DOLFUSS ROOT & CO Middleburg Hts - DOLFUSS ROOT & CO	(016) 916 1660
Powell - DOLFUSS ROOT & CO	
PUERTO RICO.	(014) /01-0/25
Caguas - Comp Rep Assoc, INC	/R00) 746-6550
UTAH.	(000) 140-0000
Murray - FRONT RANGE MARKETING	(801) 288-2500
WASHINGTON.	(55.) 200 2000
Kirkland - Electra Technical Sales	(206) 821-7442
WISCONSIN.	(22) 42 442
Pewaukee -INDUSTRIAL REPRESENTATIVE	S.(414) 574-9393

#### South American Representatives

BRAZIL.
ICOTRON TECHNOLOGIA

Advanced Micro Devices reserves the right to make changes in its product without notice in order to improve design or performance characteristics. The performance characteristics listed in this document are guaranteed by specific tests, guard banding, design and other practices common to the Industry. For specific testing details, contact your local AMD sales representative. The company assumes no responsibility for the use of any circuits described herein.





One AMD Place, P.O. Box 3453, Sunnyvale, CA 94088-3463 • 408-732-2400

• TWX 910-339-9280 • TELEX 34-6306 • 800-538-8450 • http://www.amd.com

TECHNICAL SUPPORT & LITERATURE ORDERING - USA & CANADA 800-222-9323

© 1998 Advanced Micro Devices, Inc. CPI-4M-5/98-0 4/22/97 21606C

• USA PC CPU Technical Support 408-749-3060 • Japan: 03-3346-7550 • Fax: 03-3346-9628 • Far East: Fax: 852-2966-0599 • Europe & UK: +44-(0)-1276-803299

• Fax: +44-(0)-1276-803298 • BBS +44-(0)-1276-803211 • France: 0800-908621 • Germany: 089-450-53199 • Italy: 1678-77224 • Argentina: 001-800-200-1111, after tone 888-253-8500 • Brazil: 000-811-718-5573 • Chile: 800-570-048 • Mexico: 95-800-263-4758 • PC CPU Technical Support E-mail: hwsupt@brahms.amd.com

• Europe Technical Support E-mail: euro.tech@amd.com • Europe Literature Request E-mail: euro.lit@amd.com